PTO/SB/08A (10-01)

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Sheet 1 of

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Application Number	10/077.958	L' ma	EIVED
Filing Date	02/19/2002	1 4 4. 3 6	
First Named Inventor	Michael L. Weiner	•	_
Art Unit	3739	JUL (8 2002
Examiner Name			
Attorney Docket Number	BTI-22	TECHNOLOGY	CENTER R3700

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Attorney Docket Number BTI-22 TECHNOLOGY CENTER R3700

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Application Number	10/077.958	
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First Named Inventor	Michael L. Weiner	
Group Art Unit	3739	
Examiner Name		
Attorney Docket Number	BTL-22	

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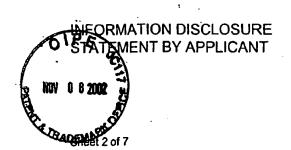
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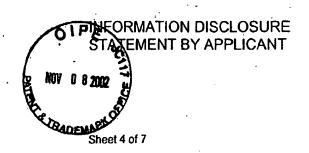
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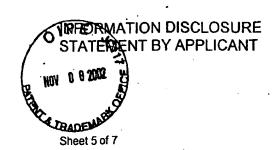
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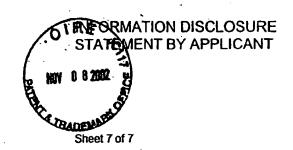
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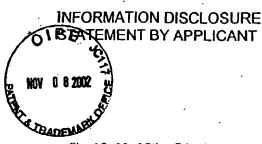
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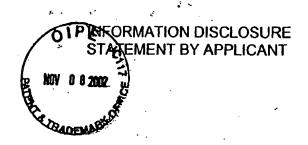
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